

Search Notes

Application/Control No.

10/519,521

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

CHOI ET AL.

Art Unit

1742

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG Pub	Search	1/8/2007	JPS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	1/8/2007	JPS
PALM Inventor Name Search	1/8/2007	JPS